

L Number	Hits	Search Text	DB	Time stamp
1	165	(liquid adj crystal adj display or LCD) and shift adj register\$1 and (reverse or backward) adj order	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:03
2	165	(liquid adj crystal adj display or LCD) and shift adj register\$1 and shift\$9 and (reverse or backward) adj order	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:04
3	125	(liquid adj crystal adj display or LCD) and shift adj register\$1 and shift\$9 and clock and (reverse or backward) adj order	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:04
4	82	(liquid adj crystal adj display or LCD) and shift adj register\$1 and shift\$9 and clock and sequential and (reverse or backward) adj order	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:06
5	9	(liquid adj crystal adj display or LCD) and shift adj register\$1 and shift\$9 and clock and sequential and (reverse or backward) adj order and scan\$9 adj line\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:06
6	5	(liquid adj crystal adj display or LCD) and shift adj register\$1 and shift\$9 and clock and sequential and (reverse or backward) adj order and scan\$9 adj line\$1 and TFT and gate	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:07
8	0	(liquid adj crystal adj display or LCD) and shift adj register\$1 and shift\$9 and clock and sequential and (reverse or backward) adj order and scan\$9 adj line\$1 and TFT and gate and matrix and test and pattern	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:08
9	0	(liquid adj crystal adj display or LCD) and shift adj register\$1 and shift\$9 and clock and sequential and (reverse or backward) adj order and scan\$9 adj line\$1 and TFT and gate and matrix and test\$9 and pattern	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:08
7	5	(liquid adj crystal adj display or LCD) and shift adj register\$1 and shift\$9 and clock and sequential and (reverse or backward) adj order and scan\$9 adj line\$1 and TFT and gate and matrix	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:08
-	385	345/90.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 12:12
-	307307	345/90.ccls. (liquid adj crystal adj display or LCD)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 12:13
-	308	345/90.ccls. and (liquid adj crystal adj display or LCD)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 12:13
-	0	345/90.ccls. and (liquid adj crystal adj display or LCD) and method adj test\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 12:14

-	23	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:08
-	21	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:08
-	6	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:09
-	6	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:09
-	3	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9 and reverse	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:10
-	2	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9 and reverse and sequential	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:10
-	3	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9 and reverse and (sequential or order)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:11
-	3	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9 and reverse and (sequential or order) and TFT	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:11
-	3	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9 and reverse and (sequential or order) and TFT and detect\$9 and defect\$9	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:12
-	2	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9 and reverse and (sequential or order) and TFT and detect\$9 and defect\$9 and low and high and pattern	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:13
-	2	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9 and reverse and (sequential or order) and TFT and detect\$9 and defect\$9 and low and high and pattern and pixel	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/29 17:13
-	3	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9 and reverse and (sequential or order) and TFT and detect\$9 and defect\$9 and low and high	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:25

-	6	345 ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 06:23
-	1019	(liquid adj crystal adj display or LCD) and method adj test\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:25
-	12	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:55
-	7	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 adj circuit and control\$9	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:26
-	7	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 adj circuit\$1 and control\$9	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:27
-	1	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 adj circuit\$1 and control\$9 and reverse and (sequential or order)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:27
-	1	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 adj circuit\$1 and control\$9 and reverse and (sequential or order) and TFT and detect\$9 and defect\$9 and low and high	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:28
-	2	345/90.ccls. and (liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 and circuit and control\$9 and reverse and (sequential or order) and TFT and detect\$9 and defect\$9 and low and high and pattern and pixel\$1 and cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:45
-	1	(liquid adj crystal adj display or LCD) and method and (test\$6 adj pattern) and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 adj circuit and control\$9 and reverse and (sequential or order) and TFT and detect\$9 and defect\$9 and pixel\$1 and cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:47
-	1	(liquid adj crystal adj display or LCD) and method and (test\$6 adj pattern) and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 adj circuit and control\$9 and (reverse and (sequential or order)) and TFT and detect\$9 and defect\$9 and pixel\$1 and cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:47
-	1	(liquid adj crystal adj display or LCD) and (test\$6 adj pattern) and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 adj circuit and control\$9 and (reverse and (sequential or order)) and TFT and detect\$9 and defect\$9 and pixel\$1 and cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:47

-	1	(liquid adj crystal adj display or LCD) and (test\$6 adj pattern) and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 adj circuit and control\$9 and (reverse and (sequential or order)) and TFT and detect\$9 and (defect\$9 and pixel\$1 and cell\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:48
-	1	(liquid adj crystal adj display or LCD) and (test\$6 adj pattern) and matrix and (data or signal) adj line\$1 and (scan\$6 or gate) adj line\$1 and driv\$9 adj circuit and control\$9 and (reverse and (sequential or order)) and TFT and detect\$9 and (defect\$9 and pixel\$1 and cell\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:48
-	1	(liquid adj crystal adj display or LCD) and (test\$6 adj pattern) and matrix and (data or signal) adj line\$1 and (scan\$6 or gate) adj line\$1 and driv\$9 adj circuit\$1 and control\$9 and (reverse and (sequential or order)) and TFT and detect\$9 and (defect\$9 and pixel\$1 and cell\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:49
-	1	(liquid adj crystal adj display or LCD) and (test\$6 adj pattern) and matrix and (data or signal) and (scan\$6 or gate) and line\$1 and driv\$9 adj circuit\$1 and control\$9 and (reverse and (sequential or order)) and TFT and detect\$9 and (defect\$9 and pixel\$1 and cell\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:49
-	6	(liquid adj crystal adj display or LCD) and method and test\$6 and matrix and data adj line\$1 and scan\$6 adj line\$1 and driv\$9 adj circuit and control\$9 and reverse and (sequential or order) and TFT and detect\$9 and defect\$9 and low and high and pattern and pixel\$1 and cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:49
-	313	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:03
-	18	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and (pixel\$1 adj defect\$9)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:56
-	13	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and detect and (pixel\$1 adj defect\$9)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:57
-	2	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and detect\$9 and (pixel\$1 adj defect\$9) and pixel\$1 adj cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 07:58
-	14	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and detect\$9 and (pixel\$1 adj defect\$9)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:02
-	41	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and test adj pattern\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:05

-	39	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and test adj pattern\$1 and detect\$9	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:09
-	2	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and test adj pattern\$1 and detect\$9 and (pixel\$1 adj defect\$9)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:11
-	0	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and test adj pattern\$1 and detect\$9 and (reverse and (sequential or order)) and (pixel\$1 adj defect\$9) and cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:11
-	1	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and test adj pattern\$1 and detect\$9 and (reverse and (sequential or order)) and pixel\$1 and defect\$9 and cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:12
-	1	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and test adj pattern\$1 and detect\$9 and (reverse and (sequential or order)) and pixel\$1 and defect\$9	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:12
-	6	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and test adj pattern\$1 and detect\$9 and (reverse and (sequential or order)) and pixel\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:13
-	8	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and test adj pattern\$1 and detect\$9 and (reverse and (sequential or order))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:13
-	2	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and test adj pattern\$1 and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:22
-	5	(liquid adj crystal adj display or LCD) and matrix and (method adj test\$6 and pattern\$1) and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:23
-	5	(liquid adj crystal adj display or LCD) and matrix and (method adj test\$6 and pattern\$1) and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1 and scan\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:24
-	5	(liquid adj crystal adj display or LCD) and matrix and (method adj test\$6 and pattern\$1) and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1 and (scan\$6 or gate\$1) and (data or signal) and line\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:25
-	5	(liquid adj crystal adj display or LCD) and matrix and (method adj test\$6 and pattern\$1) and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1 and (scan\$6 or gate\$1) and (data or signal) and line\$1 and (order or sequence\$9)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:26
-	0	(liquid adj crystal adj display or LCD) and matrix and (method adj test\$6 and pattern\$1) and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1 and (scan\$6 or gate\$1) and (data or signal) and line\$1 and (order or sequence\$9) and reverse	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:26

-	0	(liquid adj crystal adj display or LCD) and matrix and (method adj test\$6 and pattern\$1) and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1 and (scan\$6 or gate\$1) and (data or signal) and line\$1 and (order or sequence\$9) and reverse and (TFT or thin adj film adj transistor\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:27
-	1	(liquid adj crystal adj display or LCD) and matrix and (method adj test\$6 and pattern\$1) and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1 and (scan\$6 or gate\$1) and (data or signal) and line\$1 and (order or sequence\$9) and (reverse or backward) and (TFT or thin adj film adj transistor\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 08:29
-	5	(liquid adj crystal adj display or LCD) and matrix and (method adj test\$6 and pattern\$1) and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1 and (scan\$6 or gate\$1) and (data or signal) and line\$1 and (order or sequence\$9) and (TFT or thin adj film adj transistor\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 13:46
-	15	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and scan\$9 and (reverse adj order)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:04
-	3	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and scan\$9 and (reverse adj order) and sequential	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 14:56
-	11	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and scan\$9 and (reverse and order and sequential)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:07
-	20	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and (scan\$9 or gate) and (reverse and order and sequential) and (data or signal) and line\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:08
-	4	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and (scan\$9 or gate) and (reverse and order and sequential) and (data or signal) and line\$1 and (detect\$9 and pixel\$1 and defect)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:09
-	4	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and (scan\$9 or gate) and (reverse and order and sequential) and (data or signal) and line\$1 and (detect\$9 and pixel\$1 and defect) and (pixel\$1 and cell\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:10
-	3	(liquid adj crystal adj display or LCD) and method adj test\$6 and (test and pattern\$1) and matrix and (scan\$9 or gate) and (reverse and order and sequential) and (data or signal) and line\$1 and (detect\$9 and pixel\$1 and defect) and (pixel\$1 and cell\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:18
-	0	(liquid adj crystal adj display or LCD) and method adj test\$6 and (test and pattern\$1) and matrix and (scan\$9 or gate) and (reverse adj order) and (data or signal) and line\$1 and (detect\$9 and pixel\$1 and defect) and (pixel\$1 and cell\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:20

-	0	(liquid adj crystal adj display or LCD and method adj test\$6 and (test adj pattern\$1) and matrix and (reverse adj order)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:20
-	0	(liquid adj crystal adj display or LCD) and method adj test\$6 and (test adj pattern\$1) and matrix and (reverse or backward) adj order	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:21
-	1	(liquid adj crystal adj display or LCD) and method adj test\$6 and (test adj pattern\$1) and (reverse or backward) adj order	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 09:22
-	10	(liquid adj crystal adj display or LCD) and test\$6 and (test adj pattern\$1) and (reverse or backward) adj order	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/31 11:03
-	3	(liquid adj crystal adj display or LCD) adj test\$6 and (test adj pattern\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 13:09
-	12	(liquid adj crystal adj display or LCD) and test\$6 and (test adj pattern\$1) and defect\$6 adj pixel	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 13:10
-	12	(liquid adj crystal adj display or LCD) and test\$6 and (test adj pattern\$1) and defect\$6 adj pixel\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 13:10
-	4	(liquid adj crystal adj display or LCD) and matrix and (method adj test\$6 and pattern\$1) and detect\$9 and (pixel\$1 adj defect\$9) and cell\$1 and (scan\$6 or gate\$1) and (data) and line\$1 and (order or sequence\$9) and (TFT or thin adj film adj transistor\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 13:46
-	0	(liquid adj crystal adj display or LCD) and test\$6 and (test adj pattern\$1) and (reverse or backward) adj order and defect\$9 adj pixel\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 14:33
-	0	(liquid adj crystal adj display or LCD) and test\$6 and (test adj pattern\$1) and (reverse or backward) adj order and defect\$9 and pixel\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 14:33
-	1	(liquid adj crystal adj display or LCD) and method adj test\$6 and matrix and scan\$9 and (reverse adj order) and sequential and defect\$9	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 14:56
-	2	(liquid adj crystal adj display or LCD) and test\$6 and (test adj pattern\$1) and (reverse or backward) adj order and defect\$9	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/30 14:58